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PATENTS
Attorney Docket No. SMY-114.01
SUN040081/SPL

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
David L. Detlefs)	
)	Art Unit: Not yet assigned
Application No: 10/799,186)	
)	Confirmation No.: Not yet assigned
Filed: March 12, 2004)	
)	Examiner: Not yet assigned
For: EXPLOITING POPULAR OBJECTS TO)	
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CERTIFICATE OF MAILING

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Shirine M. Darvish

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Sir:

INFORMATION-DISCLOSURE STATEMENT

Applicant hereby brings to the Examiner's attention the references listed on the accompanying form PTO-1449. A copy of each listed non-U.S. Patent reference is enclosed.

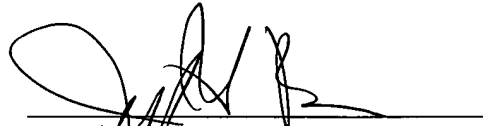
To the extent required by 37 C.F.R. §1.98(a)(3), Applicant has described what Applicant considers to be the relevance of any foreign-language reference.

Please charge any additional fee occasioned by this paper to our Deposit Account

No. 06-1448, Reference SMY-114.01.

Respectfully submitted,

Date: July 12, 2004
Customer No: 25181
Patent Group
Foley Hoag, LLP
155 Seaport Blvd.
Boston, MA 02210-2600



Joseph H. Born, Reg. No. 28,283
Attorney for Applicants
Tel. No. (617) 832-1134
Fax. No. (617) 832-7000

Form PTO-1449

**INFORMATION DISCLOSURE CITATION
IN AN APPLICATION**
(Use several sheets if necessary)

JUL 14 2004

Docket Number (Optional)
SMY-114.01Application Number
10/799,186Applicant
Detlefs et al.Filing Date
March 12, 2004Group Art Unit
Not yet assigned**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA	US 6,434,576	08/13/02	Alexander T. Garthwaite	707	206	08/19/99
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	AL						
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS*(Including Author, Title, Date, Pertinent Pages Etc.)*

AQ	BEN-YITZHAK, Ori, et al. "An Algorithm for Parallel Incremental Compaction," In Proceedings of 2002 International Symposium on Memory Management, ACM, 2002, pp. 100-105.
AR	LANG, Bernard and DUPONT, Francis. "Incremental Incrementally Compacting Garbage Collection," In Programming of Future Generation Computers II, Elsevier, 1988, pp. 163-182.
AS	JONES, Richard and LINS, Rafael. "Garbage Collection Algorithms for Automatic Dynamic Memory Management," John Wiley & Sons Ltd., Copyright 1996, West Sussex, England, Chapter 7, pp. 143-181.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

Form PTO-1449

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	BA					
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	BG					
	BH					
	BI					
	BJ					
	BK					

FOREIGN PATENT DOCUMENTS

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						YES	NO
	BL						
	BM						
	BN						
	BO						
	BP						

OTHER DOCUMENTS*(Including Author, Title, Date, Pertinent Pages Etc.)*

	BQ	BACON, David E., et al. "The Metronome: A Simpler Approach to Garbage Collection in Real-Time Systems," R. Meersman and Z. Tari (Eds.): OTM Workshops 2003, LNCS 2889, pp. 466-478, 2003.
	BR	
	BS	

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DATE CONSIDERED

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